Deive the expression for the concentration of dedhom in conduction band of semiconductor and of hole in the valence band. The concentration of electrons in the conduction band is given by ~ p(€)4(€) dE ___ Ne = p(E) is fermi-dirake distribution f(e) = and *p(e)= Now egri) be comes, (E-E)2

=
$$\int \frac{kme^{2me}}{h^2} \int_{ex}^{\infty} \left(e^{-ex}\right)^{\frac{1}{2}} \int \frac{de}{e^{-\frac{ex}{kat}}} de$$

Now equil) becomes,

$$Ne = \frac{1}{2\pi i^{2}} \left(\frac{2me}{h^{2}} \right)^{2/2} \int_{e}^{\infty} \frac{(E-E_{c})}{(E-E_{c})} e^{-\frac{1}{2}E} \frac{1}{4} \frac{1}{2} \frac{1}{2} \frac{1}{4} \frac{1}{2} \frac{1}{2} \frac{1}{4} \frac{1}{2} \frac{1}{4} \frac{1}{2} \frac{1}{4} \frac{1}{2} \frac{1}{4} \frac$$

$$Ne = \frac{1}{2\pi^2} \left(\frac{2me}{\hbar^2} \frac{k_3 \overline{f}}{\sqrt{2}} \right)^{3/2} \int_{\mathbb{C}^2} \frac{(E - E_C)}{k_B T} e^{-\frac{1}{2}} \frac{1}{\sqrt{2}E} \frac{2E_C + E_C - E_C}{\sqrt{2}E}$$

$$ne = \frac{1}{2\pi l^2} \left(\frac{2me}{h^2} \frac{k_B T}{k} \right)^{\frac{3}{2}} \left(\frac{e - e_c}{k_B T} \right) - \left(\frac{e_c - e_t}{k_B T} \right) -$$

let
$$n = G - Pc$$
 kBT

$$dn = dE$$
 kBT

Nown

$$ne = \underline{1} \quad [2me kBT] \quad e \quad kBT \quad n' \cdot e^{-x} dn.$$

$$= \underline{1} \quad [4me kBT] \quad [4] \quad [4] \quad [5a]$$

$$= \underline{1} \quad [4me kBT] \quad [4] \quad [4] \quad [5a]$$

Stundard integration.

$$ne = \underline{1} \quad [4me kBT] \quad [4] \quad [4] \quad [4] \quad [4] \quad [4]$$

$$= \underline{1} \quad [4me kBT] \quad [4me kBT]$$

This gives the concentration of electron in Lond uction band of pure seniconductor.

* Hole concentration in Intristric semiconductor

-) the hole concentration in intristric cenicunductor is given by

$$\frac{1}{\sqrt{2}} = \frac{1}{\sqrt{2}} \left(\frac{2m}{4} \right)^{3/2} = \frac{1}{\sqrt{2}} \left(\frac{2m}{4} \right)$$

where aquilibrium femi-dirale distribution function for hole is given by

$$fh(e) = 1 - fe(e) = 1 - 1$$

$$\left(\frac{e - ff}{k v T} + 1\right)$$

$$= \left(\begin{array}{c} \left(\begin{array}{c} -f_{1} \\ e \end{array}\right) - \left(\begin{array}{c} -f_{2} \\ h_{2} \end{array}\right) - \left(\begin{array}{c} -f_{3} \\ h_{2} \end{array}\right)$$

$$= \frac{e^{\frac{(-1)}{k_{R}T}}}{\left[e^{\frac{(-1)}{k_{R}T}} + 1\right]}$$

For holes E (E) in e her L L and e KRT + 1 2 P p(E) = 1 (2mh) 32 E/2 is replaced by Ev-E for holes $p(E) = \frac{1}{2\pi^2} \left(\frac{2m}{h^2}\right)^{3/2} \left(\frac{E_V - E}{V}\right)^{\frac{1}{2}}$ using-the femi-direct too distribution function and density of state for holes in the equil we have $\frac{1}{2\pi^2} \left(\frac{2mh}{h^2} \right)^{3/2} \left(\frac{1}{4} \left(\frac{1}{4} \right)^{3/2} \right) = \frac{1}{4\pi^2} \left(\frac{1}{4} \left(\frac{1}{4} \right)^{3/2} \right) =$ $\frac{1}{112}\left(\frac{2mh}{h^2}k_BT\right)^{\frac{2}{2}}\left(\frac{Ev-P}{k_BT}\right)^{\frac{2}{2}}\frac{e^{-E_+}}{k_BT}$

$$\begin{array}{c} r_{p} = \frac{1}{171^{2}} \begin{pmatrix} z_{mh} \times k_{B}T \\ h^{2} \end{pmatrix}^{\frac{1}{2}} \begin{pmatrix} \varepsilon_{v} \cdot \varepsilon_{v} \\ k_{B}T \end{pmatrix}^{\frac{1}{2}} \begin{pmatrix} \varepsilon_{v} \cdot \varepsilon_{v} \cdot \varepsilon_{v} \cdot \varepsilon_{v} \\ k_{B}T \end{pmatrix}^{\frac{1}{2}} \begin{pmatrix} \varepsilon_{v} \cdot \varepsilon_{v} \cdot \varepsilon_{v} \cdot \varepsilon_{v} \\ k_{B}T \end{pmatrix}^{\frac{1}{2}} \begin{pmatrix} \varepsilon_{v} \cdot \varepsilon_{v} \cdot \varepsilon_{v} \\ k_{B}T \end{pmatrix}^{\frac{1}{2}} \begin{pmatrix} \varepsilon_{v} \cdot \varepsilon_{v} \cdot \varepsilon_{v} \\ k_{B}T \end{pmatrix}^{\frac{1}{2}} \begin{pmatrix} \varepsilon_{v} \cdot \varepsilon_{v} \cdot \varepsilon_{v} \\ k_{B}T \end{pmatrix}^{\frac{1}{2}} \begin{pmatrix} \varepsilon_{v} \cdot \varepsilon_{v} \cdot \varepsilon_{v} \\ k_{B}T \end{pmatrix}^{\frac{1}{2}} \begin{pmatrix} \varepsilon_{v} \cdot \varepsilon_{v} \cdot \varepsilon_{v} \\ k_{B}T \end{pmatrix}^{\frac{1}{2}} \begin{pmatrix} \varepsilon_{v} \cdot \varepsilon_{v} \\ k_$$

where		0/
Nh = 1	(2mh KR7.)	in) L
547	to	(4)

· Eq 777) gives the hole conch in intristnic semiconducter.

Derive témienency for the lathistic ceniconducter

As we know that electron concr must be equal to hole concr in the intristic servicenducter

X

ne is electron concr i.e

Nh = Nh e KBT

Now eq 7 ?) can be written as E+-ee = EV-A

Nee het = Nhe ust

Since, fermi energy exist in the band at & T=OK Hence

 $G = \frac{E(+E)}{2} + 0 = \frac{E(+E)}{2} - \frac{O(-1)}{2}$

This gives the gerni expression in intrisall semiconductor and shows that termi energy has been miderity of conductions and energy and valence band energy.

Show that product of eletron and hole conco is constant for intristic semiconductor.

According to law of action of mans the product of hole and electron concr is equal to square of concr of intristic seniconductor. Let ni be the concr of intristic seniconductor. Then,

ni = ne = nh

· nenh = (ni) 2 = cont - i)

Man,

ne = He e 1/1 /2 /2 me kg [] 2

 $\frac{1}{2712}\left(\frac{11}{4}\right)^{1/2}\left(\frac{2mh \ kg1}{h^2}\right)^{3/2}$ Now eq i) becomes,

 $\frac{\eta_{1}^{2} - he \cdot hh}{2 + 1} = \frac{1}{2\pi^{2}} \left(\frac{\pi}{4} \right)^{1/2} \left(\frac{2mh R_{B}T}{h^{2}} \right)^{1/2} \left(\frac{\pi}{4} \right)^{1/2} \left(\frac{$

 $= \frac{1}{4 + 14} \times \left(\frac{2 + 13 + 1}{4 + 14}\right)^{\frac{3}{2}} \left(\frac{1}{4 + 14}\right)^{\frac{$

for intrinse sent conductor which is constant.

It verifies the lawy man of action. for instructions

field Effect Transistar

*

the transistor which, depends on majority charge carrier and electrons are controlled by electric field connected with the electroide is known as field effect transistan

the transistor has only kind of majority.

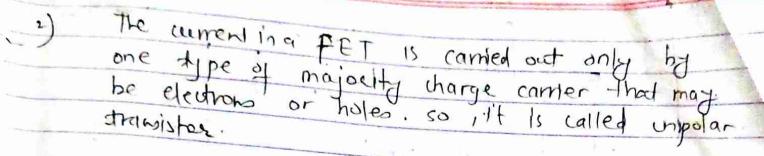
charge carrier . S., it is called .

unipolar strumisher.

Emille

The tenders of field affect Transistors (FFT)

They are voltage controlled device. The wirest through the device is controlled by an electric field associated with a voltage placed at an electrode called gate. This features give the name of field affect Transistor,



1) JFET (Junction field Effect Transister)

MOSFET (Metal oxide servicon ducter field Effect
Transister)

gate

Source Hyii)

Source Hyii)

P-channel IFGT

